

Notice of References Cited

Application/Control No.

09/887,475

Applicant(s)/Patent Under Reexamination NAVON, YAAKOV

Examiner

Yubin Hung

Applicant(s)/Patent Under Reexamination NAVON, YAAKOV

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	ÚS-5,995,659	11-1999	Chakraborty et al.	382/176
	В	US-5,506,913	04-1996	Ibison et al.	382/132
	O	US-6,633,409	10-2003	Yamazaki, Yoshirou	358/1.9
	D	US-6,064,778	05-2000	Pasco et al.	382/289
	E	US-6,195,474	02-2001	Snyder et al.	382/312
	F	US-5,770,841	06-1998	Moed et al.	235/375
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10224626 A	08-1998	Japan	TAMAOKI, SHUNPEI	H04N 01/403
	0	JP 08272965 A	10-1996	Japan	CHIBA et al.	G06T 07/00
	Р					
	Q					
	R		. ,			
	s					
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
*	٦	Messelodi et al., 'Automatic Identification and Skew Estimation of Text Lines in Real Scene Images,' Pattern Recognition 3 (1999), pp. 791-810			
	٧	English translation of JP 08-272965			
	w	English translation of JP 10-224626			
	х				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.